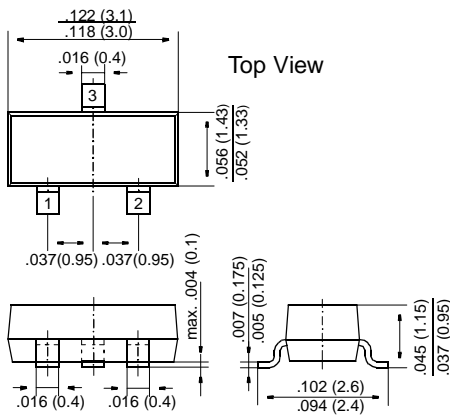


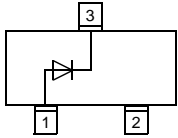
BAS19, BAS20, BAS21

Small Signal Diodes

SOT-23



Dimensions in inches and (millimeters)



Top View

Marking

BAS19 = A8
 BAS20 = A81
 BAS21 = A82

FEATURES

- ◆ Silicon Planar Epitaxial High-Speed Diodes
- ◆ For switching and general purpose applications.
- ◆ These diodes are also available in other case styles including: the SOD-123 case with the type designation BAV19W - BAV21W, the MiniMELF case with the type designation BAV101 - BAV103, and the DO-35 case with the type designation BAV19 - BAV21.



MECHANICAL DATA

Case: SOT-23 Plastic Package

Weight: approx. 0.008 g

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Value	Unit
Continuous Reverse Voltage	BAS19	100	V
	BAS20	150	V
	BAS21	200	V
Repetitive Peak Reverse Voltage	BAS19	120	V
	BAS20	200	V
	BAS21	250	V
Non-Repetitive Peak Forward Current at t = 1 μs at t = 1 s	I _{FSM}	2.5	A
	I _{FSM}	0.5	A
Average Rectified Forward Current (averaged over any 20 ms period)	I _{F(AV)}	200 ¹⁾	mA
Forward DC Current at T _{amb} = 25 °C	I _F	200 ²⁾	mA
Repetitive Peak Forward Current	I _{FRM}	625	mA
Power Dissipation up to T _{amb} = 25 °C	P _{tot}	200 ²⁾	mW
Junction Temperature	T _j	150	°C
Storage Temperature Range	T _S	-65 to +150	°C

1) Measured under pulse conditions; Pulse time = t_p ≤ 0.3 ms.

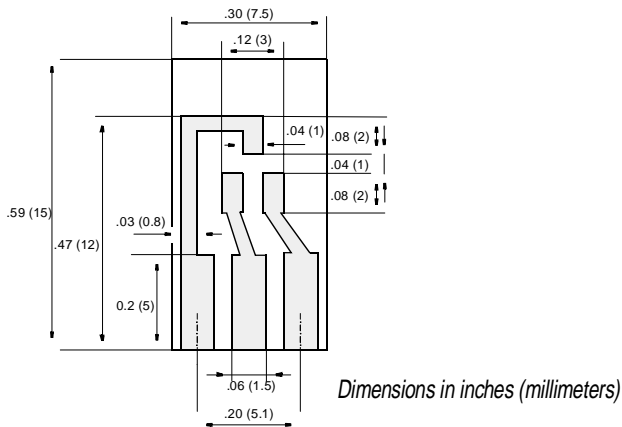
2) Device on fiberglass substrate, see layout.

BAS19, BAS20, BAS21

ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Min.	Typ.	Max.	Unit
Forward Voltage at $I_F = 100 \text{ mA}$ at $I_F = 200 \text{ mA}$	V_F V_F	– –	– –	1.0 1.25	V V
Leakage Current at $V_R = V_{Rmax}$ at $V_R = V_{Rmax}; T_j = 150 \text{ }^\circ\text{C}$	I_R I_R	– –	– –	100 100	nA μA
Dynamic Forward Resistance at $I_F = 10 \text{ mA}$	r_f	–	5	–	Ω
Capacitance at $V_R = 0, f = 1 \text{ MHz}$	C_{tot}	–	–	5	pF
Reverse Recovery Time (see figures) from $I_F = 30 \text{ mA}$ through $I_R = 30 \text{ mA}$ to $I_R = 3 \text{ mA}$, $R_L = 100 \text{ } \Omega$	t_{rr}	–	–	50	ns
Thermal Resistance Junction to Ambient Air	R_{thJA}	–	–	430 ²⁾	K/W
2) Device on fiberglass substrate, see layout.					

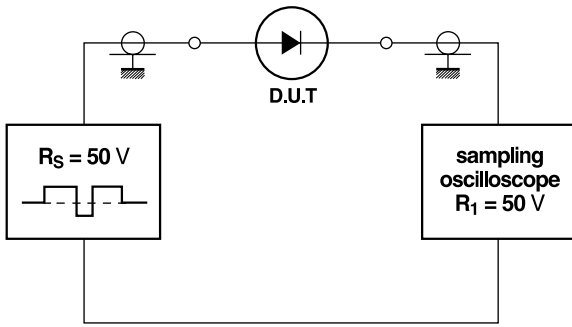


Layout for R_{thJA} test

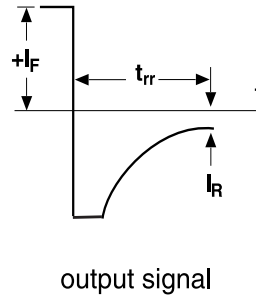
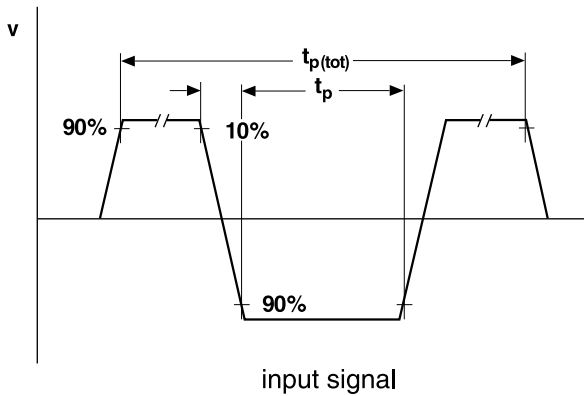
Thickness: Fiberglass 0.059 in (1.5 mm)

Copper leads 0.012 in (0.3 mm)

Test Circuit and Waveforms BAS19, BAS20, BAS21



Test circuit



Waveforms; $I_R = 3 \text{ mA}$

Input Signal

- total pulse duration	$t_{p(\text{tot})} = 2 \mu\text{s}$
- duty factor	$\delta = 0.0025$
- rise time of reverse pulse	$t_r = 0.6 \text{ ns}$
- reverse pulse duration	$t_p = 100 \text{ ns}$

Oscilloscope

- rise time	$t_r = 0.35 \text{ ns}$
- circuit capacitance*	$C < 1 \text{ pF}$

*C = oscilloscope input capacitance + parasitic capacitance